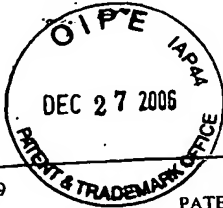


Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 119199		APPLICATION NO. 10/807,280	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Yoshitaka SASAKI et al.			
				FILING DATE March 24, 2004		GROUP 3729	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
ADT	1	JP-A-07-110917	04/25/1995	JAPAN	XX	XX	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER				DATE CONSIDERED			
/A. Dexter Tugbang/				1/25/07			
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Date: November 21, 2006

Sheet 1 of 1Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

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Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
ADT	1	JP-A-11-273027	10/08/1999	JAPAN	X	X
ADT	2	JP-A-2003-288705	10/10/2003	JAPAN	X	X

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, etc.)

Examiner Initials	Cite No.	

EXAMINER

/A. Dexter Tugbang/

DATE CONSIDERED
1/25/07

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: December 27, 2006